

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,021	WEI ET AL.	
Examiner	Art Unit	
Chun Crowder	1644	

SEARCHED					
Class	Subclass	Date	Examiner		
<u> </u>					

Subclass	Date	Examiner
		1
	- 1	
		<u></u>

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor search in PALM, EAST, and STN	3/29/2006	c.c		
EAST (all databases)	3/29/2006			
STN (medline, embase, biosis, caplus)	3/29/2006			
Sequence search by STIC	3/27/2006			
USSN 09/820,004	3/29/2006	C.C		
·				